

24V Dual N-Channel Mosfet

FEATURES

- $R_{SS(ON)}=7.8\text{m}\Omega(\text{Typ.}) @ V_{GS}=4.5\text{V}$
- $R_{SS(ON)}=8.2\text{m}\Omega(\text{Typ.}) @ V_{GS}=3.9\text{V}$
- $R_{SS(ON)}=9.7\text{m}\Omega(\text{Typ.}) @ V_{GS}=2.5\text{V}$

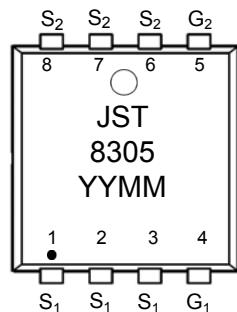
TDFN3*3-8L



APPLICATIONS

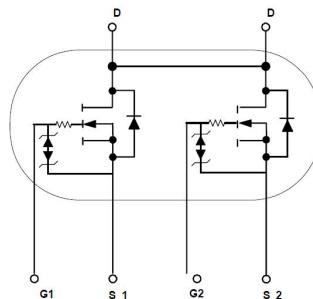
- Portable appliances
- Power management

MARKING



YYMM:Date Code(year & month)

N-CHANNEL MOSFET

MAXIMUM RATINGS ($T_c=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Min	Max	Unit
V_{DS}	Drain-Source Voltage	24	-	V
V_{GS}	Gate-Source Voltage	-	± 12	V
I_D	Drain Current ^{note1} $V_{GS}=4.5\text{V}$	-	58	A
I_{DM}	Pulsed Drain Current ^{note1,note2,note3} $V_{GS}=4.5\text{V}$	-	100	A
P_{tot}	Total Power Dissipation ^{note1}	$T_c=25^\circ\text{C}$	-	31
		$T_c=100^\circ\text{C}$	-	12.4
T_{stg}	Storage Temperature	- 55	150	$^\circ\text{C}$
T_J	Junction Temperature	-	150	$^\circ\text{C}$
I_S	Diode Forward Current ^{note1}	-	58	A
R_{eJC}	Thermal Resistance- Junction to Ambient ^{note1}	-	4	$^\circ\text{C} / \text{W}$

MOSFET ELECTRICAL CHARACTERISTICS $T_C=25\text{ }^\circ\text{C}$ unless otherwise specified

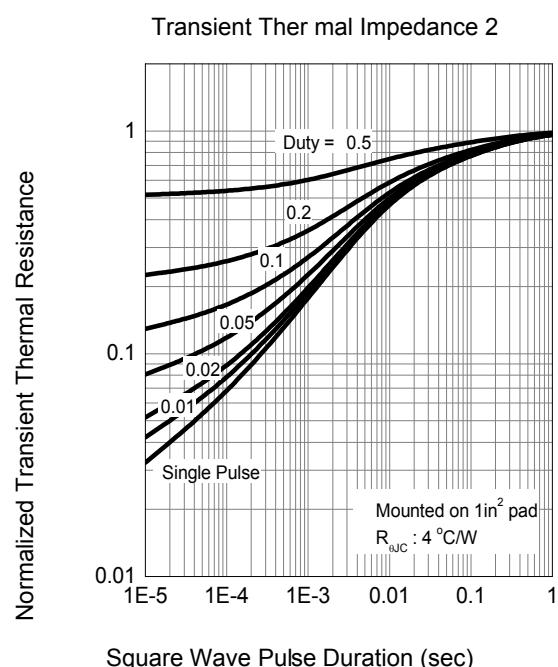
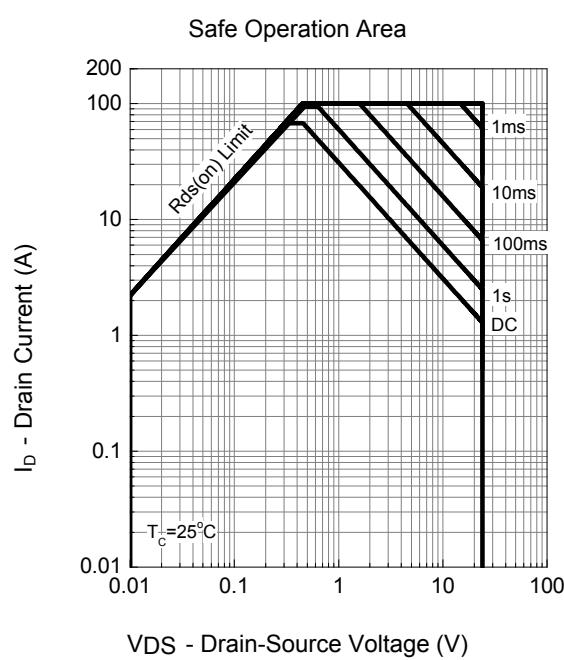
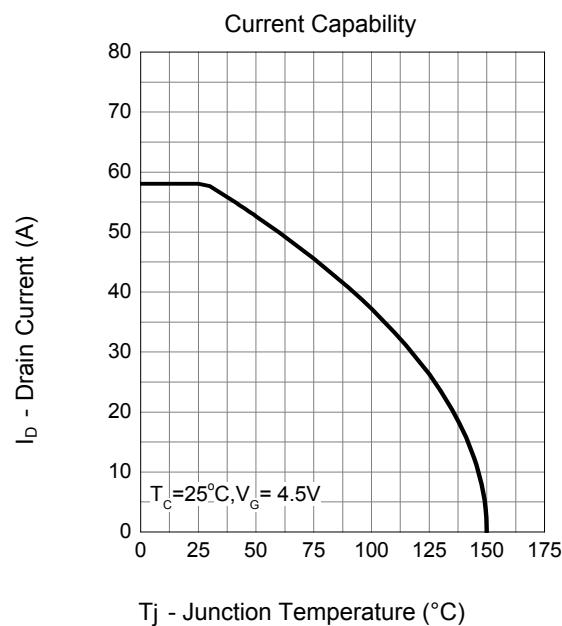
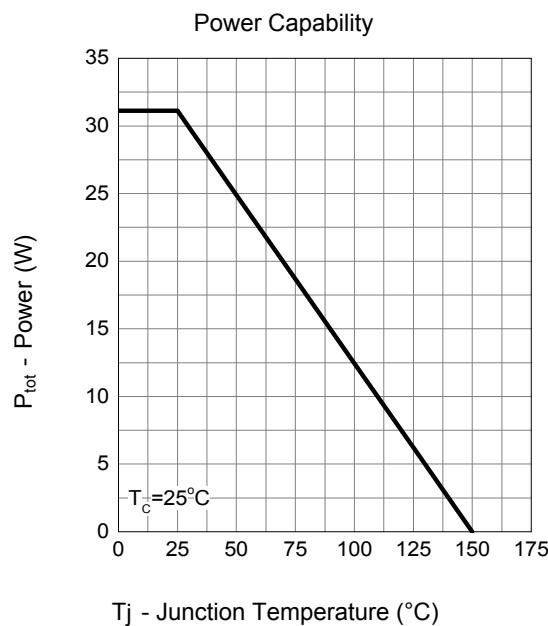
Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Static Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0\text{ V}, I_{DS} = 250\text{ }\mu\text{A}$	24	-	-	V
$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{DS} = 250\text{ }\mu\text{A}$	0.5	-	1.0	V
I_{DSS}	Drain Leakage Current	$V_{DS} = 20\text{ V}, V_{GS} = 0\text{ V}$ $T_J = 85\text{ }^\circ\text{C}$	-	-	1	μA
I_{GSS}	Gate Leakage Current	$V_{GS} = \pm 10\text{ V}, V_{DS} = 0\text{ V}$	-	-	± 10	μA
$R_{SS(\text{ON})}$	Static Source to Source On-Resistance ^{note2}	$V_{GS} = 4.5\text{ V}, I_{DS} = 8\text{ A}$	-	7.8	9.0	$\text{m}\Omega$
		$V_{GS} = 3.9\text{ V}, I_{DS} = 8\text{ A}$	-	8.2	9.7	
		$V_{GS} = 2.5\text{ V}, I_{DS} = 8\text{ A}$	-	9.7	11	
Diode Characteristics						
V_{SD}	Diode Forward Voltage ^{note2}	$I_{SD} = 1\text{ A}, V_{GS} = 0\text{ V}$	-	-	1.3	V
Dynamic Characteristics^{note4}						
C_{iss}	Input Capacitance	$V_{GS} = 0\text{ V}, V_{DS} = 10\text{ V}$ $f = 1\text{ MHz}$	-	2322	-	pF
C_{oss}	Output Capacitance		-	300	-	
C_{rss}	Reverse Transfer Capacitance		-	277	-	
$t_d(\text{on})$	Turn-on Delay Time	$V_{DS} = 10\text{ V}, V_{GEN} = 4.5\text{ V},$ $R_G = 6\text{ }\Omega, R_L = 3.3\text{ }\Omega,$ $I_{DS} = 3\text{ A}$	-	8.3	-	ns
t_r	Turn-on Rise Time		-	34.6	-	
$t_d(\text{off})$	Turn-off Delay Time		-	406.7	-	
t_f	Turn-off Fall Time		-	189.8	-	
Gate Charge Characteristics^{note4}						
Q_g	Total Gate Charge	$V_{GS} = 4.5\text{ V}, V_{DS} = 10\text{ V},$ $I_{DS} = 3\text{ A}$	-	41.1	-	nC
Q_{gs}	Gate-Source Charge		-	2.9	-	
Q_{gd}	Gate-Drain Charge		-	12.2	-	

Notes: 1. Surface Mounted on 1 in² pad area, $t \leq 10\text{ sec}$

- 2 . Pulse width $\leq 300\text{ }\mu\text{s}$, duty cycle $\leq 2\%$
3. limited by bonding wire
- 4 . Guaranteed by design, not subject to production testing.

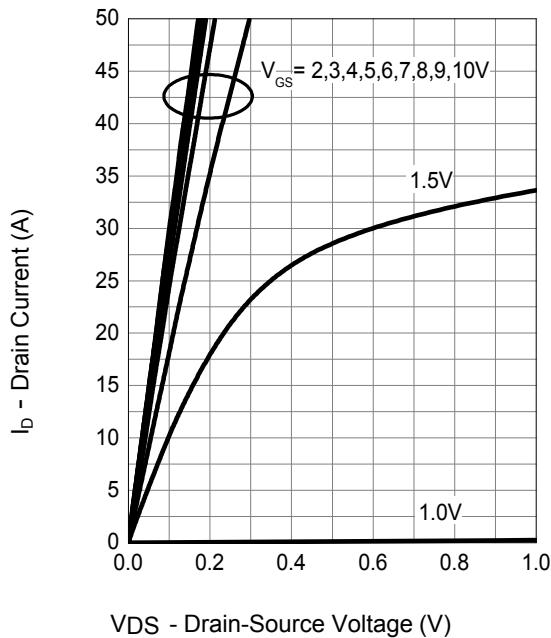
Typical Characteristics

N-channel:

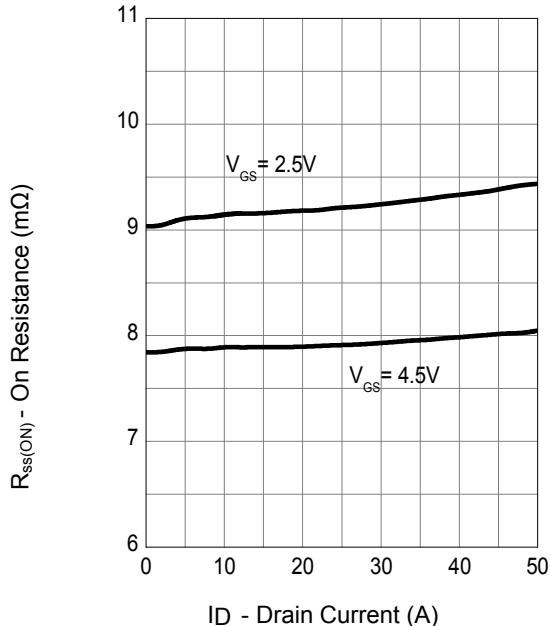


Typical Performance Characteristics (cont.)

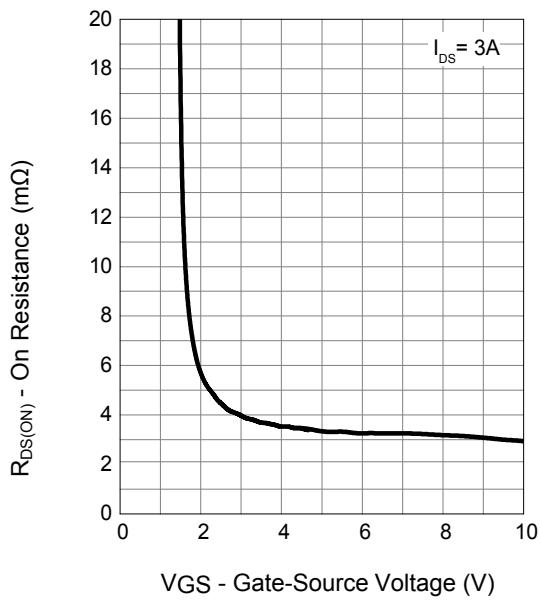
Output Characteristics



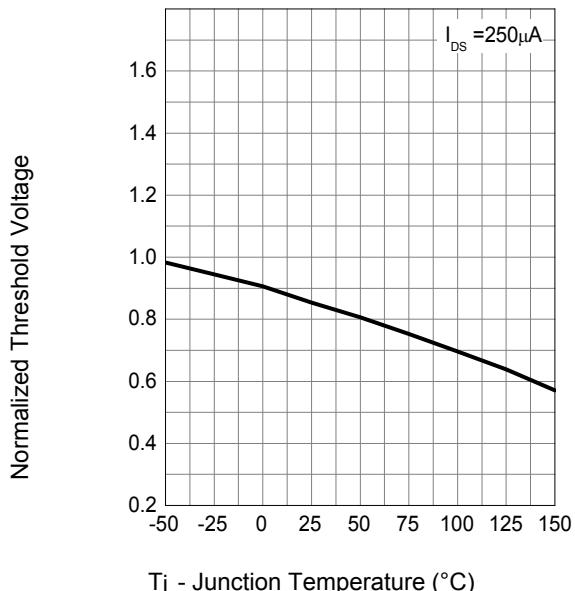
On Resistance



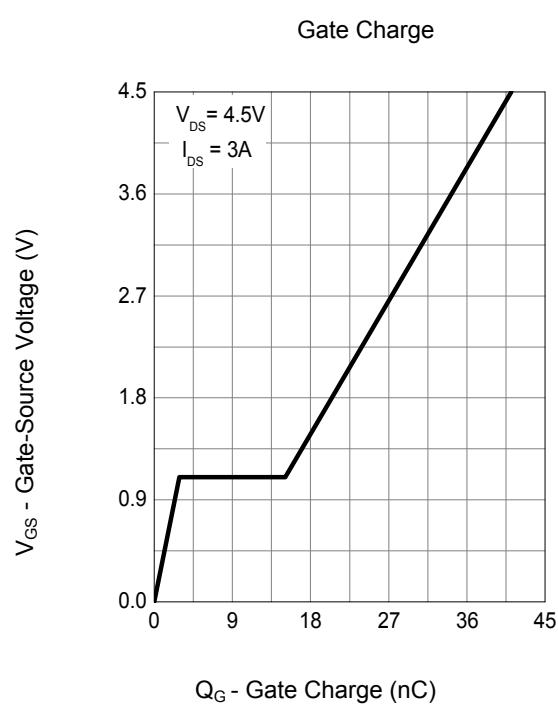
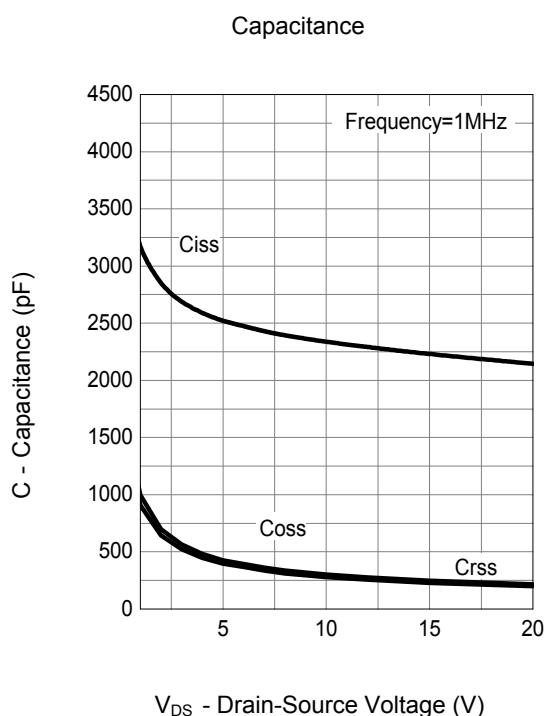
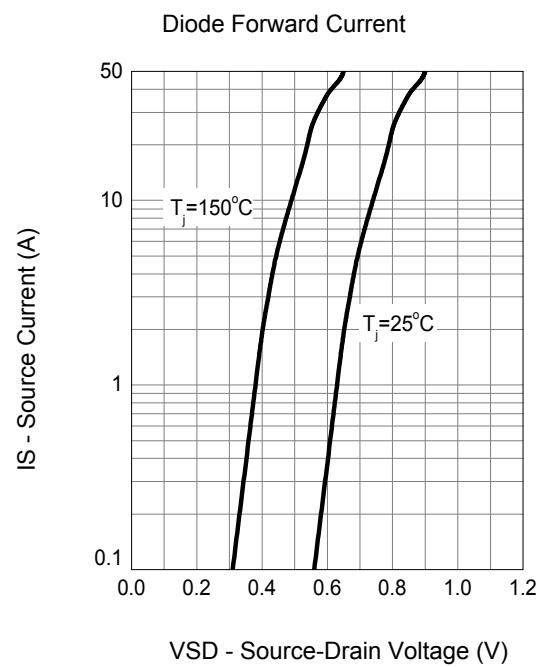
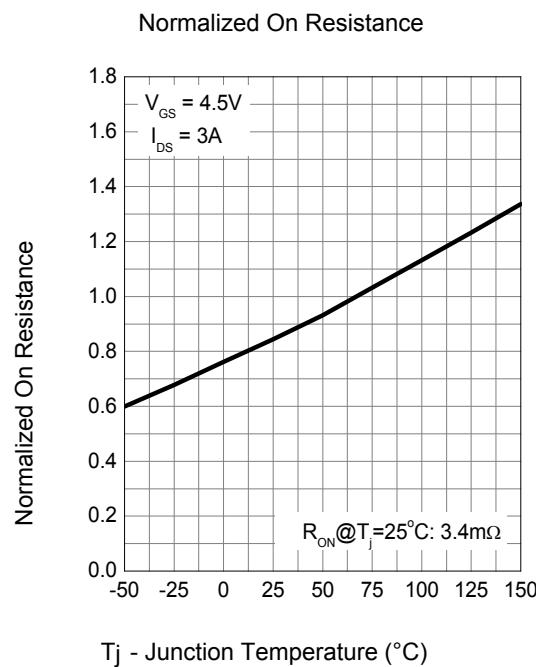
Transfer Characteristics



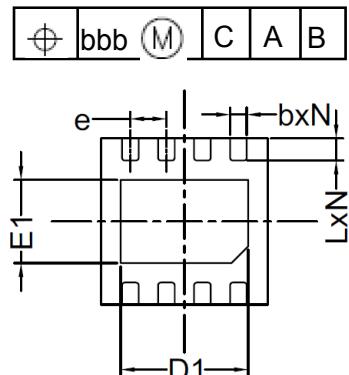
Normalized Threshold Voltage 1.8



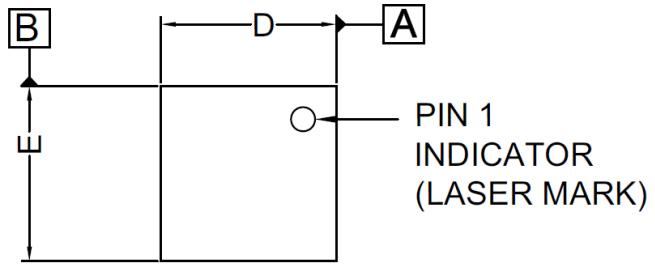
Typical Performance Characteristics (cont.)



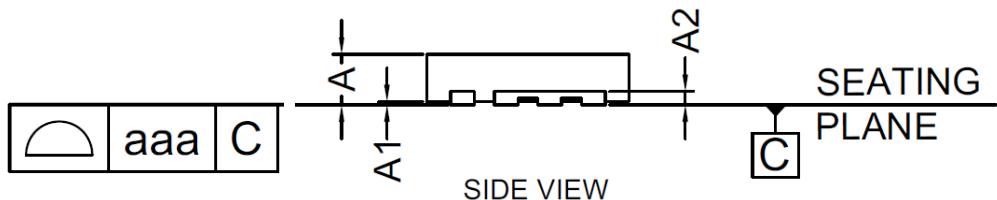
TDFN3*3-8L PACKAGE OUTLINE DRAWING



BOTTOM VIEW



TOP VIEW



SIDE VIEW

UNITS OF MEASURE=MILLIMETER

Symbol	Min	TYP	MAX
A	0.70	0.75	0.80
A1	0.00	0.02	0.05
A2		0.203	
b	0.25	0.30	0.35
D	2.924	3.00	3.076
D1	2.20	2.30	2.40
E	2.924	3.00	3.076
E1	1.40	1.50	1.60
e		0.65BSC	
L	0.35	0.40	0.45
K	0.20	-	
N		8	
aaa		0.08	
bbb		0.10	